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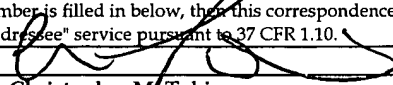
IN THE
UNITED STATES PATENT AND TRADEMARK OFFICE

APPLICANTS: David Alumot, Gad Neumann,
Rivka Sherman & Ehud Tirosh

PRIOR APPLICATION:

SERIAL NO.: 07/790,871
FILING DATE: November 12, 1991
TITLE: TWO-PHASE OPTICAL INSPECTION METHOD AND APPARATUS
FOR DEFECT DETECTION
EXAMINER: A. Johns
GROUP ART UNIT: 2606
OLD ATTY. DKT. NO.: 2822US

NEW ATTY. DKT. NO.: 3154US

CERTIFICATE OF MAILING			
I hereby certify that this correspondence, including the enclosures identified above, is being deposited with the United States Postal Service as first class mail in an envelope addressed to: The Assistant Commissioner for Patents, Washington, D.C. 20231 on the date shown below. If the Express Mail Mailing Number is filled in below, then this correspondence is being deposited with the United States Postal Service "Express Mail Post Office to Addressee" service pursuant to 37 CFR 1.10.			
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BOX PATENT APPLICATION
ASSISTANT COMMISSIONER FOR PATENTS
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PRELIMINARY AMENDMENT

Kindly enter the following amendments in the above-referenced case.

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